

Multi-Site MOSFET Test System-STS8202



➤ System Features

- Up to 16 Sites MOSFET test in parallel, focus on wafer testing to improve throughput
- Up to $\pm 100V/\pm 10A$ test capability per site with $\pm 1000V/\pm 10mA$ and AC test options (UIS/Ciss/Coss/Crss/Rg)
- Menu driven programming
- 32 sites True Parallel Test Solution available; Support "TWIN" test mode
- Flexible expansion to Analog IC tester or Mixed Signal tester under **CROSS** mainframe

➤ Source Board with Feature

Board Name	Main Feature
FVI10	● 1 channel floating V/I with $\pm 100V/\pm 10A$ pulsed, 16-Bit Force/Measure
HVI1K	● 1 channel floating V/I, $\pm 1000V/\pm 10mA$, 16-Bit Force/Measure
DC Test Box	● Support DC test items with low Rdson and low leakage test module built-in
UIS100	● UIS Test up to 20A,1000V Voltage Detector
ZMU	● Impedance measurement unit for Cg/Rg ,100K-1MHz, DC bias up to $\pm 40V$

Note: Correct specifications depend on the actual model all specifications are subject to change without prior notice.

